


<b>Search Notes</b>  	<b>Application/Control No.</b>  10581395	<b>Applicant(s)/Patent Under Reexamination</b>  TAN ET AL.
	<b>Examiner</b>  DAVID GOODWIN	<b>Art Unit</b>  2818

SEARCHED			
Class	Subclass	Date	Examiner
438	613 614 652 666 118	7/31/09	dg
257	783 778	7/31/09	dg

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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